Notice of References Cited Application/Control No. 10/542,004 Examiner XIAOLIANG CHEN Applicant(s)/Patent Under Reexamination FREIMUTH ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-5,318,461 A	06-1994	Frikkee et al.	439/715	
*	В	US-5,629,831 A	05-1997	Eggert et al.	361/624	
*	С	US-5,984,734 A	11-1999	Piper et al.	439/717	
*	D	US-6,027,379 A	02-2000	Hohorst, Wolfgang	439/715	
*	Е	US-6,081,048 A	06-2000	Bergmann et al.	307/147	
*	F	US-6,231,400 B1	05-2001	Nagai, Kentaro	439/701	
*	G	US-6,332,812 B1	12-2001	Kazuhara, Hitoshi	439/701	
*	Н	US-2002/0072266 A1	06-2002	Lange, Oliver	439/358	
*	I	US-2004/0106331 A1	06-2004	Hoegener et al.	439/701	
*	J	US-6,783,403 B2	08-2004	Lafragette et al.	439/717	
*	К	US-2006/0134956 A1	06-2006	Freimuth et al.	439/166	
*	L	US-5,652420 A	07-1997	Innes et al.	200/50.32	
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.